

IGBT Chip in NPT-technology

Features:

- 1200V NPT technology
- low turn-off losses
- positive temperature coefficient
- easy paralleling

This chip is used for:

 power module BUP 314

Applications:

drives



| Chip Type | V _{CE} | <i>I</i> c | Die Size | Package |
|-------------|------------------------|------------|-----------------------------|--------------|
| SIGC42T120C | 1200V | 25A | 6.59 x 6.49 mm ² | sawn on foil |

Mechanical Parameter

| moonamour aramotor | | | | |
|---------------------------------|--|-----|--|--|
| Raster size | 6.59 x 6.49 | | | |
| Emitter pad size | 2 x (1.58 x 2.18) | mm² | | |
| Gate pad size | 1.06 x 0.65 | | | |
| Area total | 42.8 | | | |
| Thickness | 200 | μm | | |
| Wafer size | 150 | mm | | |
| Max.possible chips per wafer | 334 | | | |
| Passivation frontside | Photoimide | | | |
| Pad metal | 3200 nm AlSiCu | | | |
| Backside metal | Ni Ag –system suitable for epoxy and soft solder die bonding | | | |
| Die bond | Electrically conductive glue or solder | | | |
| Wire bond | Al, <500μm | | | |
| Reject ink dot size | Ø 0.65mm ; max 1.2mm | | | |
| Recommended storage environment | Store in original container, in dry nitrogen, in dark environment, < 6 month at an ambient temperature of 23°C | | | |



Maximum Ratings

| Parameter | Symbol | Value | Unit |
|---|---------------------|--|------|
| Collector-Emitter voltage, T_{vj} =25 °C | V _{CE} | 1200 | V |
| DC collector current, limited by $T_{\rm vjmax}$ | I _C | 1) | А |
| Pulsed collector current, t_p limited by $T_{vj \text{ max}}$ | I _{c,puls} | 75 | А |
| Gate emitter voltage | V _{GE} | ±20 | V |
| Junction temperature range | T_{vj} | -55 +175 | °C |
| Operating junction temperature | T _{vj} | -55+150 | °C |
| Short circuit data ²⁾ $V_{GE} = 15V$, $V_{CC} = 900V$, $T_{vj} = 150$ °C | $t_{	t SC}$ | 10 | μs |
| Reverse bias safe operating area ²⁾ (RBSOA) | I _{C,max} | = 50A, $V_{CE,max} = 1200$ \ $T_{vj} \le 150$ °C | I |

¹⁾ depending on thermal properties of assembly

Static Characteristic (tested on wafer), $T_{\rm vj}$ =25 °C

| Parameter | Symbol | Conditions | Value | | | Unit |
|--------------------------------------|----------------------|--|-------|------|------|------|
| i arameter | | Conditions | min. | typ. | max. | |
| Collector-Emitter breakdown voltage | V _{(BR)CES} | $V_{\rm GE}$ =0V , $I_{\rm C}$ = 1.5mA | 1200 | | | |
| Collector-Emitter saturation voltage | V _{CEsat} | V _{GE} =15V, I _C =25A | 2.0 | 2.5 | 3.0 | V |
| Gate-Emitter threshold voltage | $V_{\rm GE(th)}$ | $I_{\rm C}$ =1mA , $V_{\rm GE}$ = $V_{\rm CE}$ | 4.5 | 5.5 | 6.5 | |
| Zero gate voltage collector current | I _{CES} | V _{CE} =1200V , V _{GE} =0V | | | 3.1 | μA |
| Gate-Emitter leakage current | I _{GES} | V_{CE} =0V , V_{GE} =20V | | | 120 | nA |
| Integrated gate resistor | $r_{\rm G}$ | | | none | | Ω |

$\textbf{Dynamic Characteristic} \ (\text{not subject to production test - verified by design / characterization}),$

 T_{vi} =25 °C

| Parameter | Symbol | Conditions | Value | | | Unit |
|------------------------------|------------------|----------------|-------|------|------|-------|
| raiametei | Symbol | Conditions | min. | typ. | max. | Ollit |
| Input capacitance | Cies | $V_{CE}=25V$, | | 1650 | | |
| Output capacitance | Coes | $V_{GE}=0V$, | | 250 | | pF |
| Reverse transfer capacitance | C _{res} | f=1MHz | | 110 | | |

²⁾ not subject to production test - verified by design/characterization

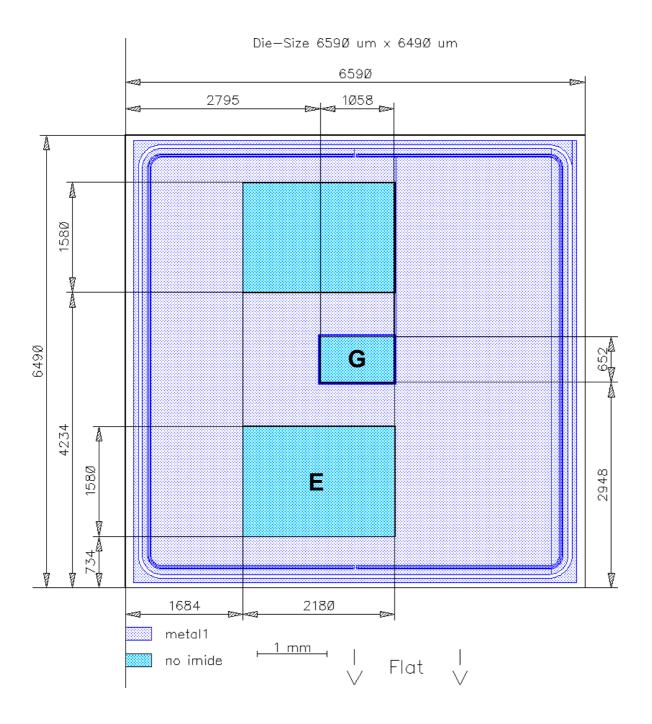


Further Electrical Characteristic

Switching characteristics and thermal properties are depending strongly on module design and mounting technology and can therefore not be specified for a bare die.



Chip Drawing



E = Emitter pad

G = Gate pad



Description

AQL 0,65 for visual inspection according to failure catalogue

Electrostatic Discharge Sensitive Device according to MIL-STD 883

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